ZX3CDBS1M832

MPPS™ Miniature Package Power Solutions 20V NPN LOW SATURATION TRANSISTOR AND 40V, 1A SCHOTTKY DIODE COMBINATION DUAL

SUMMARY

NPN Transistor — V_{CEO} = 20V; R_{SAT} = 47m Ω ; I_{C} = 4.5A Schottky Diode — V_{R} = 40V; V_{F} = 500mV (@1A); I_{C} =1A

DESCRIPTION

Packaged in the new innovative 3mm x 2mm MLP this combination dual comprises an ultra low saturation NPN transistor and a 1A Schottky barrier diode. This excellent combination provides users with highly efficient performance in applications including DC-DC and charging circuits.



Performance capability equivalent to much larger packages

Improved circuit efficiency & power levels

PCB area and device placement savings

Lower package height (0.9mm nom)

Reduced component count

FEATURES

- Extremely Low Saturation Voltage (150mV @1A)
- H_{FF} characterised up to 6A
- I_C = 4.5A Continuous Collector Current
- Extremely Low V_F, fast switching Schottky
- 3mm x 2mm MLP

APPLICATIONS

- DC DC Converters
- Mobile Phones
- Charging Circuits
- Motor control

ORDERING INFORMATION

DEVICE	REEL	TAPE WIDTH	QUANTITY PER REEL
ZX3CDBS1M832TA	7′′	8mm	3000
ZX3CDBS1M832TC	13′′	8mm	10000

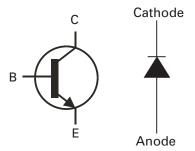
DEVICE MARKING

BS1

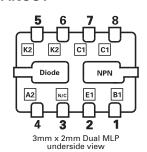
ISSUE 3- OCTOBER 2007



3mm x 2mm Dual Die MLP



PINOUT





ZX3CDBS1M832

ABSOLUTE MAXIMUM RATINGS.

PARAMETER	SYMBOL	VALUE	UNIT
Transistor	-		
Collector-Base Voltage	V _{CBO}	40	V
Collector-Emitter Voltage	V _{CEO}	20	V
Emitter-Base Voltage	V _{EBO}	7.5	V
Peak Pulse Current	I _{CM}	12	А
Continuous Collector Current (a)(f)	I _C	4.5	А
Continuous Collector Current (b)(f)	I _C	5	А
Base Current	I _B	1000	mA
Power Dissipation at TA=25°C (a)(f) Linear Derating Factor	P _D	1.5 12	W mW/°C
Power Dissipation at TA=25°C (b)(f) Linear Derating Factor	P _D	2.45 19.6	W mW/°C
Power Dissipation at TA=25°C (c)(f) Linear Derating Factor	P _D	1 8	W mW/°C
Power Dissipation at TA=25°C (d)(f) Linear Derating Factor	P _D	1.13 9	W mW/°C
Power Dissipation at TA=25°C (d)(g) Linear Derating Factor	P _D	1.7 13.6	W mW/°C
Power Dissipation at TA=25°C (e)(g) Linear Derating Factor	P _D	3 24	W mW/°C
Storage Temperature Range	T _{stg}	-55 to +150	°C
Junction Temperature	Tj	150	°C

THERMAL RESISTANCE

PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)(f)	$R_{\theta JA}$	83	°C/W
Junction to Ambient (b)(f)	$R_{\theta JA}$	51	°C/W
Junction to Ambient (c)(f)	$R_{\theta JA}$	125	°C/W
Junction to Ambient (d)(f)	$R_{\theta JA}$	111	°C/W
Junction to Ambient (d)(g)	$R_{\theta JA}$	73.5	°C/W
Junction to Ambient (e)(g)	$R_{\theta JA}$	41.7	°C/W

Notes

(a) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(b) Measured at t<5 secs for a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(c) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with minimal lead connections only.

(d) For a dual device surface mounted on 10 sq cm single sided 1oz copper on FR4 PCB, in still air conditions with all exposed pads attached attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(e) For a dual device surface mounted on 85 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(f) For a dual device with one active die.

(g) For dual device with 2 active die running at equal power.

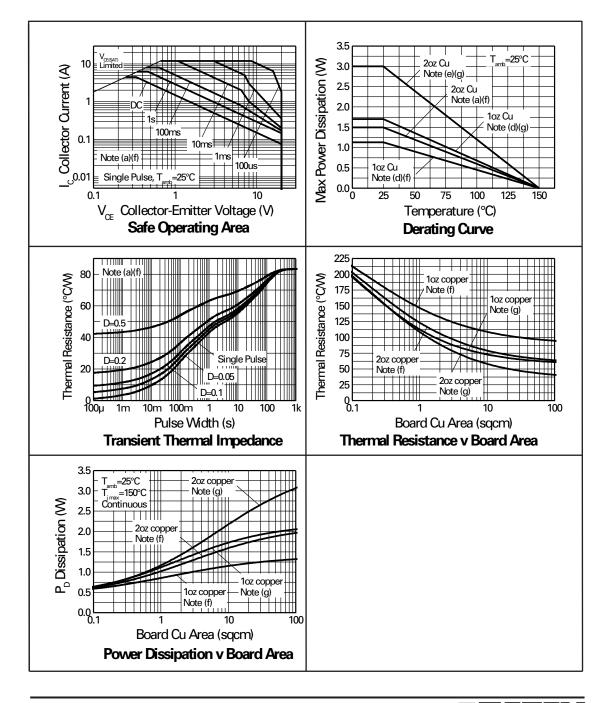
 $(h) \ Repetitive\ rating\ -\ pulse\ width\ limited\ by\ max\ junction\ temperature.\ Refer\ to\ Transient\ Thermal\ Impedance\ graph.$

(i) The minimum copper dimensions required for mounting are no smaller than the exposed metal pads on the base of the device as shown in the package dimensions data. The thermal resistance for a dual device mounted on 1.5mm thick FR4 board using minimum copper 1 oz weight, 1mm wide tracks and one half of the device active is Rth = 250°C/W giving a power rating of Ptot = 500mW.



ZX3CDBS1M832

TRANSISTOR TYPICAL CHARACTERISTICS



ZETEXSEMICONDUCTORS

ZX3CDBS1M832

ABSOLUTE MAXIMUM RATINGS.

PARAMETER	SYMBOL	VALUE	UNIT
Schottky Diode	-		
Continuous Reverse Voltage	V _R	40	V
Forward Voltage @ I _F =1000mA(typ)	V _F	425	mV
Forward Current	I _F	1850	mA
Average Peak Forward Current D=50%	I _{FAV}	3	Α
Non Repetitive Forward Current $t \le 100 \mu s$ $t \le 10 ms$	I _{FSM}	12 7	A A
Power Dissipation at TA=25°C (a)(f) Linear Derating Factor	P _D	1.2 12	W mW/°C
Power Dissipation at TA=25°C (b)(f) Linear Derating Factor	P _D	2 20	W mW/°C
Power Dissipation at TA=25°C (c)(f) Linear Derating Factor	P _D	0.8 8	W mW/°C
Power Dissipation at TA=25°C (d)(f) Linear Derating Factor	P _D	0.9 9	W mW/°C
Power Dissipation at TA=25°C (d)(g) Linear Derating Factor	P _D	1.36 13.6	W mW/°C
Power Dissipation at TA=25°C (e)(g) Linear Derating Factor	P_{D}	2.4 24	W mW/°C
Storage Temperature Range	T _{stg}	-55 to +150	°C
Junction Temperature	Ti	125	°C

THERMAL RESISTANCE

PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)(f)	$R_{\theta JA}$	83	°C/W
Junction to Ambient (b)(f)	$R_{\theta JA}$	51	°C/W
Junction to Ambient (c)(f)	$R_{\theta JA}$	125	°C/W
Junction to Ambient (d)(f)	$R_{\theta JA}$	111	°C/W
Junction to Ambient (d)(g)	$R_{\theta JA}$	73.5	°C/W
Junction to Ambient (e)(g)	$R_{\theta JA}$	41.7	°C/W

Notes

(a) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(b) Measured at t<5 secs for a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(c) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with minimal lead connections only.

(d) For a dual device surface mounted on 10 sq cm single sided 1oz copper on FR4 PCB, in still air conditions with all exposed pads attached attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(e) For a dual device surface mounted on 85 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(f) For a dual device with one active die.

(g) For dual device with 2 active die running at equal power.

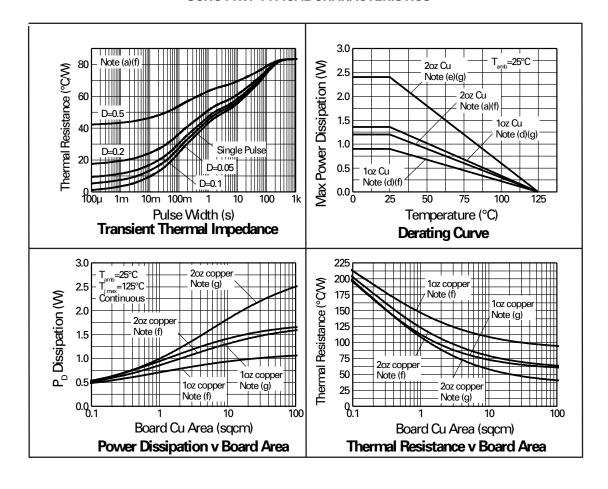
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(i) The minimum copper dimensions required for mounting are no smaller than the exposed metal pads on the base of the device as shown in the package dimensions data. The thermal resistance for a dual device mounted on 1.5mm thick FR4 board using minimum copper 1 oz weight, 1mm wide tracks and one half of the device active is Rth = 250°C/W giving a power rating of Ptot = 400mW.



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SCHOTTKY TYPICAL CHARACTERISTICS





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ELECTRICAL CHARACTERISTICS (at $T_{amb} = 25$ °C unless otherwise stated).

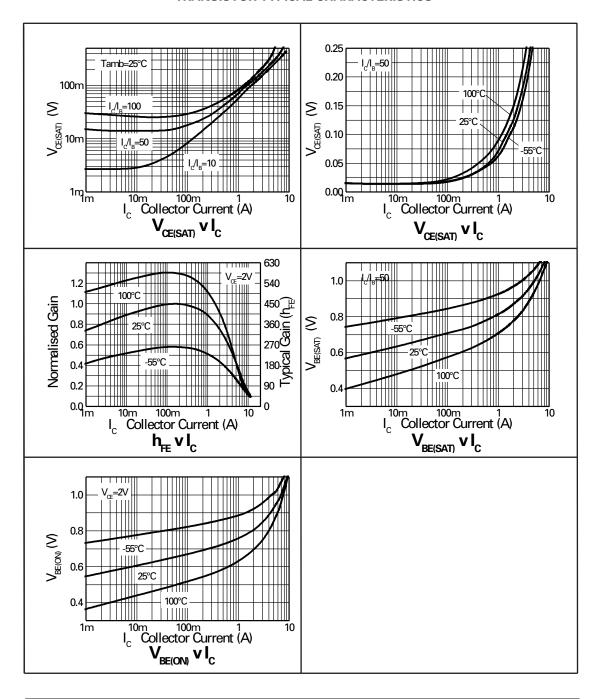
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS.		
TRANSISTOR ELECTRICAL CHARACTERISTICS								
Collector-Base Breakdown Voltage	V _{(BR)CBO}	40	100		V	I _C =100μA		
Collector-Emitter Breakdown Voltage	V _{(BR)CEO}	20	27		V	I _C =10mA*		
Emitter-Base Breakdown Voltage	V _{(BR)EBO}	7.5	8.2		V	I _E =100μA		
Collector Cut-Off Current	I _{CBO}			25	nA	V _{CB} =32V		
Emitter Cut-Off Current	I _{EBO}			25	nA	V _{EB} =6V		
Collector Emitter Cut-Off Current	I _{CES}			25	nA	V _{CES} =16V		
Collector-Emitter Saturation Voltage	V _{CE(sat)}		8 90 115 190 210	15 150 135 250 270	mV mV mV mV	I _C =0.1A, I _B =10mA* I _C =1A, I _B =10mA* I _C =2A, I _B =50mA* I _C =3A, I _B =100mA* I _C =4.5A, I _B =125mA*		
Base-Emitter Saturation Voltage	V _{BE(sat)}		0.98	-1.05	V	I _C =4.5A, I _B =125mA*		
Base-Emitter Turn-On Voltage	V _{BE(on)}		0.88	-0.95	V	I _C =4.5A, V _{CE} =2V*		
Static Forward Current Transfer Ratio	h _{FE}	200 300 200 100	400 450 360 180			I _C =10mA, V _{CE} =2V* I _C =0.2A, V _{CE} =2V* I _C =2A, V _{CE} =2V* I _C =6A, V _{CE} =2V*		
Transition Frequency	f _T	100	140		MHz	I _C =50mA, V _{CE} =10V f=100MHz		
Output Capacitance	C _{obo}		23	30	pF	V _{CB} =10V, f=1MHz		
Turn-On Time	t _(on)		170		ns	V _{CC} =10V, I _C =3A		
Turn-Off Time	t _(off)		400		ns	I _{B1} =I _{B2} =10mA		
SCHOTTKY DIODE ELECTRICAL CH	ARACTERIST	rics						
Reverse Breakdown Voltage	V _{(BR)R}	40	60		V	I _R =300μA		
Forward Voltage	V _F		240 265 305 355 390 425 495 420	270 290 340 400 450 500 600	mV mV mV mV mV mV	I _F =50mA* I _F =100mA* I _F =250mA* I _F =500mA* I _F =750mA* I _F =1000mA* I _F =1500mA* I _F =1500mA*		
Reverse Current	I _R		50	100	μΑ	V _R =30V		
Diode Capacitance	C _D		25		pF	f=1MHz,V _R =25V		
Reverse Recovery Time	t _{rr}		12		ns	switched from I _F = 500mA to I _R = 500mA Measured at I _R = 50mA		

^{*}Measured under pulsed conditions.



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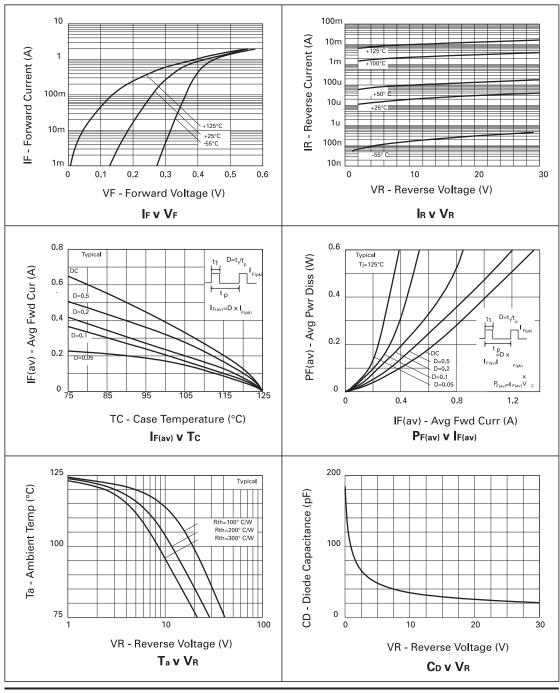
TRANSISTOR TYPICAL CHARACTERISTICS





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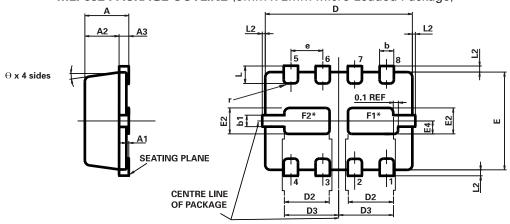
SCHOTTKY TYPICAL CHARACTERISTICS





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 $[\]hbox{*Exposed Flags. Solder connection to improve thermal dissipation is optional.}$

CONTROLLING DIMENSIONS IN MILLIMETRES APPROX. CONVERTED DIMENSIONS IN INCHES

MLP832 PACKAGE DIMENSIONS

	MILLIN	IETRES	INC	HES		MILLIMETRES		INCHES	
DIM	MIN.	MAX.	MIN.	MAX.	DIM	MIN.	MAX.	MIN.	MAX.
Α	0.80	1.00	0.031	0.039	е	0.65	REF	0.025	6 BSC
A1	0.00	0.05	0.00	0.002	Е	2.00	BSC	0.0787	7 BSC
A2	0.65	0.75	0.0255	0.0295	E2	0.43	0.63	0.017	0.0249
А3	0.15	0.25	0.006	0.0098	E4	0.16	0.36	0.006	0.014
b	0.24	0.34	0.009	0.013	L	0.20	0.45	0.0078	0.0157
b1	0.17	0.30	0.0066	0.0118	L2		0.125	0.00	0.005
D	3.00	BSC	0.118	BSC	r	0.075 BSC		0.002	9 BSC
D2	0.82	1.02	0.032	0.040	θ	0°	12°	0°	12°
D3	1.01	1.21	0.0397	0.0476					

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F1 at collector 1 potential

F2 at collector 2 potential